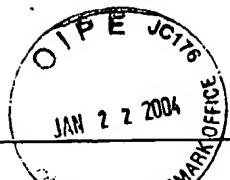


					ATTY. DOCKET NO.: 88265-6980	APPLICATION NO.: <i>10/656,955</i>	
					APPLICANT: Armand MALNOE et al.		
					FILING DATE: Herewith	GROUP:	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>M</i>	AA	5,973,004	10/1999	Howard	514	561	
	AB	5,626,849	5/1997	Hastings et al.	424	195.1	
	AC	5,916,912	6/1999	Ames et al.	514	440	
<i>M</i>	AD	6,080,788	6/2000	Sole et al.	514	561	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
							YES NO
<i>M</i>	AE	2 761 887	10/1998	France	—	—	X
<i>M</i>	AF	198 06 890	8/1999	Germany	—	—	X
<i>M</i>	AG	WO 99/66913	12/1999	PCT	—	—	X
<i>M</i>	AH	WO 00/11968	3/2000	PCT	—	—	X
<i>M</i>	AI	WO 01/58271	8/2001	PCT	—	—	X
<i>M</i>	AJ	WO 01/51088	7/2001	PCT	—	—	X
<i>M</i>	AK	WO 01/26666	4/2001	PCT	—	—	X
<i>M</i>	AL	WO 98/43617	10/1998	PCT	—	—	X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AJ						
	AK						
EXAMINER <i>Malnoe</i>				DATE CONSIDERED <i>5/27/04</i>			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

ATTY. DOCKET NO.:	APPLICATION NO.:
88265-6980	10/656,955
APPLICANT:	
Armand MALNOE et al.	
FILING DATE:	GROUP:
September 5, 2003	1614 1623

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
M	AA	4,254,147	3/1981	Cavazza	424	316	
	AB	4,330,557	5/1982	Cavazza	424	316	
	AC	4,883,672	11/1989	Shug et al.	426	2	
	AD	5,932,258	8/1999	Sunvold	426	2	
M	AE	6,022,867	2/2000	Ito et al.	514	100	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
M	AF	198 39 441 with English Abstract	8/1998	Germany	—	—	X	
M	AG	298 03 260 with English Abstract	8/1998	Germany	—	—	X	
M	AH	2 595 548 with English Abstract	891993	France	—	—	X	
M	AI	2 594 644 with English Abstract	891993	France	—	—	X	
M	AJ	WO 00/11952	9/2000	PCT	—	—	X	
M	AK	WO 00/12071 with English Abstract	3/2000	PCT	—	—	X	
M	AL	WO 00/44375	8/2000	PCT	—	—	X	
M	AM	WO 00/49891	8/2000	PCT	—	—	X	
M	AN	WO 98/44932	10/1998	PCT	—	—	X	
M	AO	WO 98/14213 with English Abstract	4/1998	PCT	—	—	X	
M	AP	WO 99/21565	6/1999	PCT	—	—	X	
	AQ							

Mukome

5/27/04

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AR	
	AS	
	AT	
	AU	
	AV	

EXAMINER <i>[Handwritten signature]</i>	DATE CONSIDERED 5/27/04
---	-----------------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>		ATTY. DOCKET NO.	APPLICATION NO.
		88265-6980	10/656,955
		APPLICANT:	Armand MALNOË et al.
		FILING DATE: Herewith	GROUP:

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AM	AA	5,973,004	10/1999	Howard	514	561	
	AB	5,626,849	5/1997	Hastings et al.	424	195.1	
	AC	5,916,912	6/1999	Ames et al.	514	440	
	AD	6,080,788	6/2000	Sole et al.	514	561	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
AM	AE	2 761 887	10/1998	France	—	—		X
AM	AF	198 06 890	8/1999	Germany	—	—		X
AM	AG	WO 99/66913	12/1999	PCT	—	—	X	
AM	AH	WO 00/11968	3/2000	PCT	—	—	X	
AM	AJ	WO 01/58271	8/2001	PCT	—	—	X	
AM	AJ	WO 01/51088	7/2001	PCT	—	—	X	
AM	AK	WO 01/26666	4/2001	PCT	—	—	X	
AM	AL	WO 98/43617	10/1998	PCT	—	—	X	

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AJ	
	AK	

EXAMINER	DATE CONSIDERED
Malnoe	5/27/04

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>	ATTY. DOCKET NO.:	APPLICATION NO.:
	88265-6980	10/656,955
	APPLICANT: Armand MALNOE et al.	
	FILING DATE: September 5, 2003	GROUP: <i>1614 1623</i>

U.S. PATENT DOCUMENTS

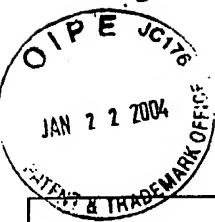
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>M</i>	AA	4,254,147	3/1981	Cavazza	424	316	
	AB	4,330,557	5/1982	Cavazza	424	316	
	AC	4,883,672	11/1989	Shug et al.	426	2	
	AD	5,932,258	8/1999	Sunvold	426	2	
<i>M</i>	AE	6,022,867	2/2000	Ito et al.	514	100	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>M</i>	AF	198 39 441 with English Abstract	8/1998	Germany	—	—	X	
<i>M</i>	AG	298 03 260 with English Abstract	8/1998	Germany	—	—	X	
<i>M</i>	AH	2 595 548 with English Abstract	891993	France	—	—	X	
<i>M</i>	AI	2 594 644 with English Abstract	891993	France	—	—	X	
<i>M</i>	AJ	WO 00/11952	9/2000	PCT	—	—	X	
<i>M</i>	AK	WO 00/12071 with English Abstract	3/2000	PCT	—	—	X	
<i>M</i>	AL	WO 00/44375	8/2000	PCT	—	—	X	
<i>M</i>	AM	WO 00/49891	8/2000	PCT	—	—	X	
<i>M</i>	AN	WO 98/44932	10/1998	PCT	—	—	X	
<i>M</i>	AO	WO 98/14213 with English Abstract	4/1998	PCT	—	—	X	
<i>M</i>	AP	WO 99/21565	6/1999	PCT	—	—	X	
	AQ							

Malnoe

5/27/04



OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AR	
	AS	
	AT	
	AU	
	AV	

EXAMINER <i>J. K. Hene</i>	DATE CONSIDERED 5/21/04
-------------------------------	----------------------------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.